Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/045,842	CORMIER ET AL.
	Examiner	Art Unit
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	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC		)
	DATE	EXMR
EIC search	3/22/2007	ECC
EAST search on fprs, epo, jpo, derwent and ibm-tdb	4/8/2007	ECC
427/2.28, 2.31	4/8/2007	ECC
reviewed inventors in PALM	4/8/2007	